

# C2012X8R1H104K125AE

TDK Item Description : C2012X8R1H104KT\*\*\*S



## Application & Main Feature

Commercial Grade ( Soft Termination )

## Series

C2012 [EIA CC0805]



## Dimensions

L	2.00mm +0.45,-0.2mm
W	1.25mm +0.25,-0.2mm
T	1.25mm +0.25,-0.2mm
B	0.20mm Min.
G	0.50mm Min.

## Temperature Characteristic

X8R (-55 to 150 degC +/-15%)

## Rated Voltage

1H (50Vdc)

## Capacitance

100nF

## Capacitance Tolerance

K (+/-10%)

## Dissipation Factor

3% Max.

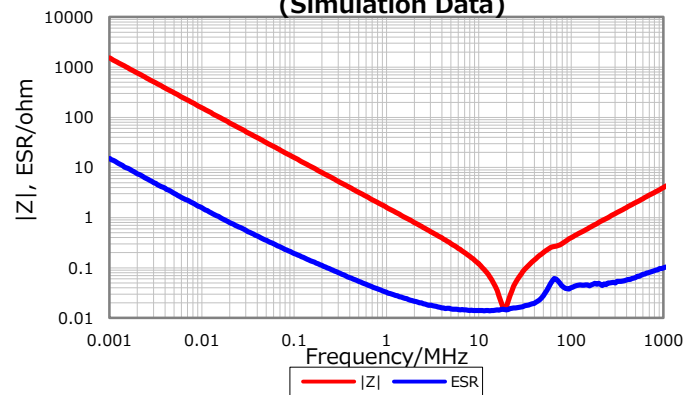
## Insulation Resistance

5Gohm Min

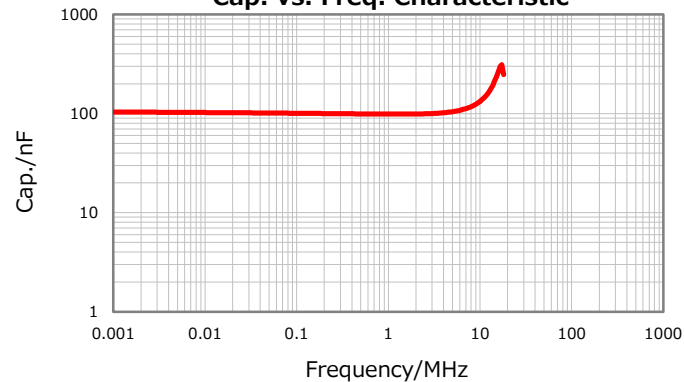
## AEC-Q200

Not Applicable

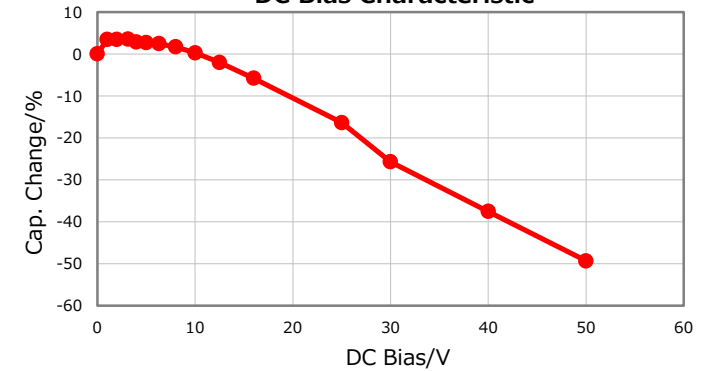
## |Z|, ESR vs. Freq. Characteristics (Simulation Data)



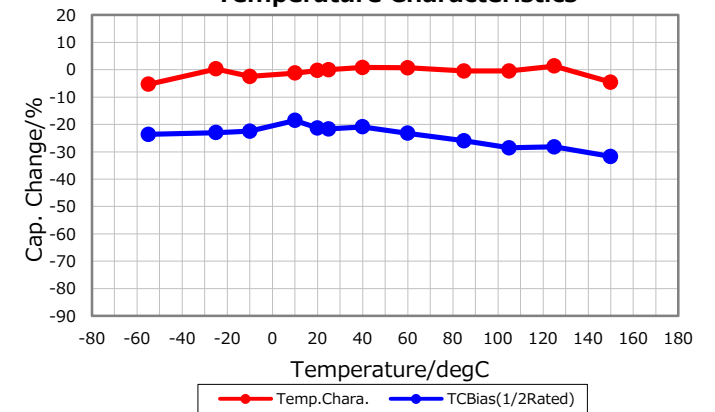
## Cap. vs. Freq. Characteristic



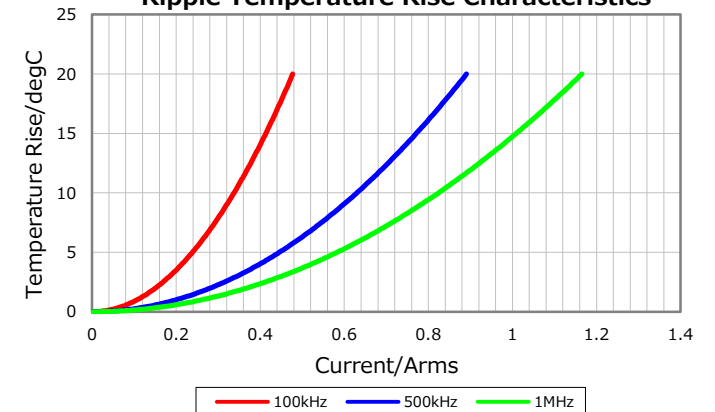
## DC Bias Characteristic



## Temperature Characteristics



## Ripple Temperature Rise Characteristics



Characterization Sheet ( Multilayer Ceramic Chip Capacitors )



All specifications are subject to change without notice.

March 16, 2017